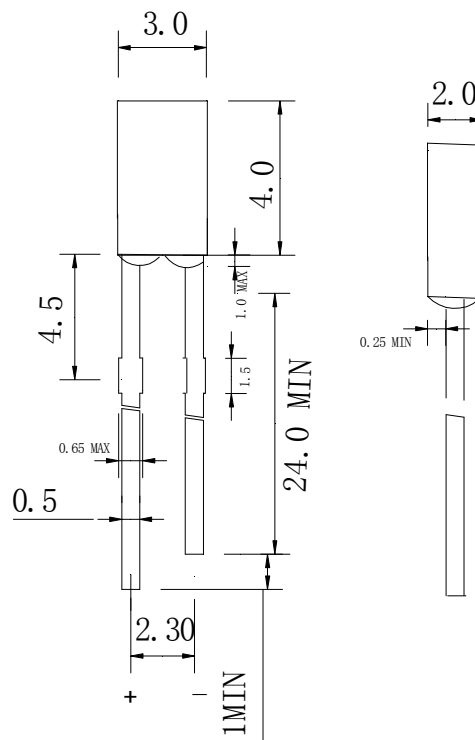


Features

- 2*3*4. DIA LED Lamp
- Low Power Consumption
- High Efficiency
- Various Colors and Viewing Angle
- Long Solid State Reliability
- Package: 1000pcs/Packing

Applications

- Indicator

Package Dimensions**Notes:**

1. All dimensions are in millimeters (inches).
2. Tolerance is $\pm 0.25\text{mm}$ (.01") unless otherwise noted.
3. Protruded Resin under flange is 1.0mm(0.04") max.
4. Specifications are subject to change without notice.

**Selection Guide**

Part No	Lens Type	Dice	Emitted Color
FDL-234GD-ZGDLTHQ-P23	Green Diffused	GaAsP	Super Green

Electrical / Optical Characteristics At Ta=25°C

Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Condition
I _v	Luminous Intensity	5.0	9.0	15.0	mcd	IF=20mA
2θ _{1/2}	Viewing Angle		175		deg	IF=20mA
λ _d	Dominant Wavelength	564	570	574	nm	IF=20mA
Δλ	Spectral Line Half-Width		35		nm	IF=20mA
V _F	Forward Voltage	2.2	2.3	2.6	V	IF=20mA
I _R	Reverse Current			10	uA	VR 5V

Note:

1. θ_{1/2} is the angle from optical centerline where the luminous intensity is 1/2 optical centerline value

Absolute Maximum Ratings At Ta=25°C

Parameter	Green	Unit
Power Dissipation	70	mW
Peak Forward Current[1]	120	mA
Continuous Forward Current	30	mA
Reverse Voltage	5	V
Operating Temperature Range	-40°C to + 85°C	
Storage Temperature Range	-40°C to + 85°C	
Soldering Condition	260°C For 5 Seconds	

Note:

1. 1/10DutyCycle, 0.1msPulseWidth

Electrical Optical Characteristics Curves At Ta=25°C

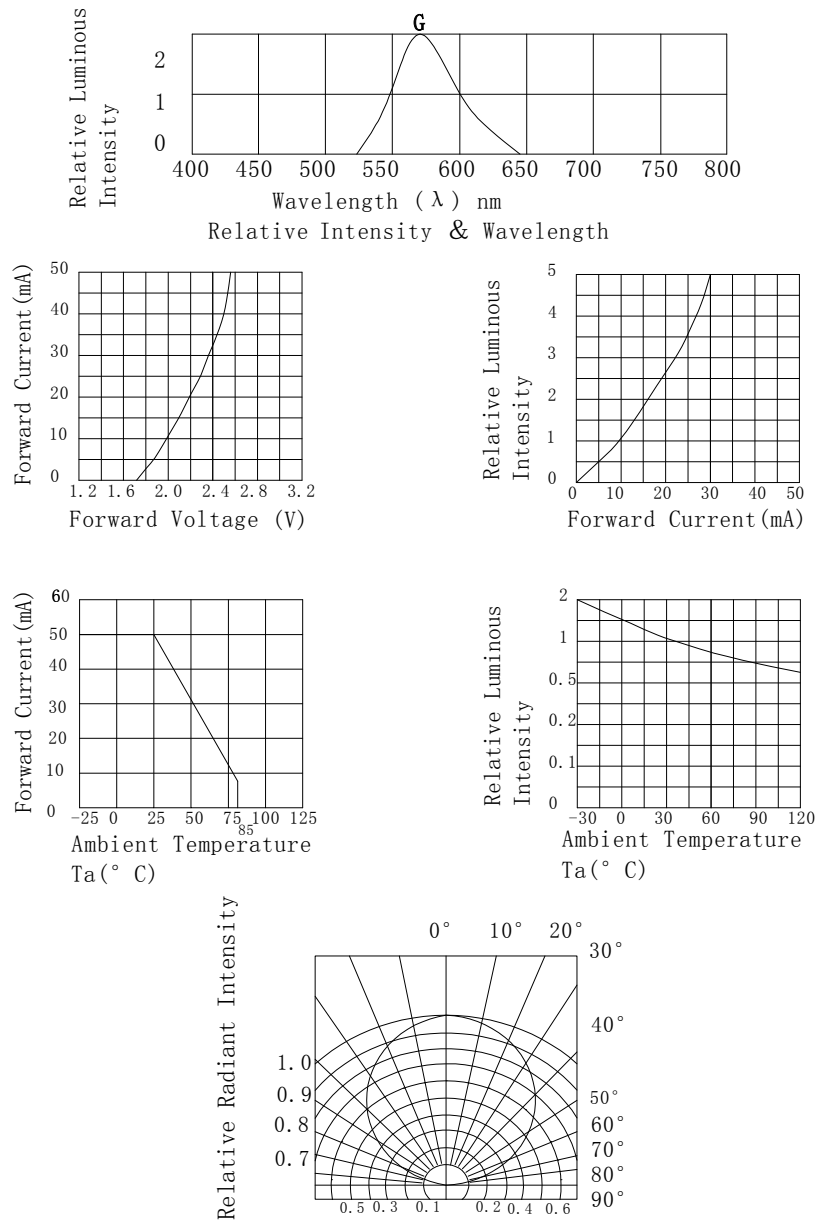


Fig.6 Radiation Diagram

Notes:

1. The LEDs should be used within a year.
2. The LEDs should be kept in 5~30°C and 60% RH for less.
3. The LEDs should be used within 24 hours, or else should be kept a 5~30°C and 30% RH or less. And LEDs should be used within 7 days after opening the package.

Reliability Test Items Conditions

Classification	Test Item	Test Conditions	Test hours	Result
Endurance Test	Opertion Life	Connect with a power $I_F=20mA$ $T_a=$ Under room temperature	1000Hrs	0/20
	Hige Temperature High Humidity	$T_a=+65^{\circ}C\pm5^{\circ}C$ RH=90%-95%	240Hrs	0/20
	Hige Temperature Storage	High $T_a=+85^{\circ}C\pm5^{\circ}C$	1000Hrs	0/20
	Low Temperature Storage	Low $T_a=-35^{\circ}C\pm5^{\circ}C$ Test time=1000hrs	1000Hrs	0/20
Environmental Test	Temperature Cycling	$-45^{\circ}C\sim+105^{\circ}C$ 15min 5min 15min	300 Cycles	0/20
	Thermal Shock	$-35^{\circ}C\sim\pm5^{\circ}C\sim+85^{\circ}C\sim\pm5^{\circ}C$ 5min 10sec 5min	300 Cycles	0/20
	Solder Resistance	Preheating: $120^{\circ}C-150^{\circ}C$,within 2 minutes. Operation heating : $260^{\circ}C$ (Max.),within5 seconds(Max.)	5Cycles	0/20

Judgment criteria of failure for the reliability

Measuring items	Symbol	Measuring conditions	Judgment criteria for failure
Forward voltage	$V_F(V)$	$I_F=20mA$	Over $U\times 1.2$
Reverse current	$I_R(\mu A)$	$V_R=5V$	Over $U\times 2$
Luminous intensity	$I_v(mcd)$	$I_F=20mA$	Below $S\times 0.5$

Note: 1.U means the upper limit of specified characteristics. S means initial value.

2.Measurment shall be taken between 2 hours after the test pieces have been returned to normal ambient conditions after completion of each test.